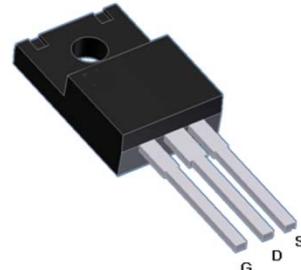
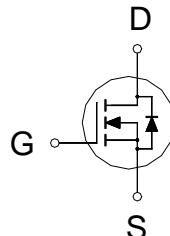


N-Channel Logic Level Enhancement Mode Field Effect Transistor
Product Summary:

BV_{DSS}	150V
$R_{DS(on)}$ (MAX.)	60m Ω
I_D	20A



UIS, Rg 100% Tested

Pb-Free Lead Plating & Halogen Free


ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Drain-Source Voltage		V_{DSS}	150	V
Gate-Source Voltage		V_{GS}	± 30	V
Continuous Drain Current	$T_C = 25^\circ\text{C}$	I_D	20	A
	$T_C = 100^\circ\text{C}$		12	
Pulsed Drain Current ¹		I_{DM}	80	
Avalanche Current		I_{AS}	18	
Avalanche Energy	$L = 0.2\text{mH}, I_D=18\text{A}, R_G=25\Omega$	E_{AS}	32.4	mJ
Repetitive Avalanche Energy ²	$L = 0.1\text{mH}$	E_{AR}	16.2	
Power Dissipation	$T_C = 25^\circ\text{C}$	P_D	35	W
	$T_C = 100^\circ\text{C}$		14	
Operating Junction & Storage Temperature Range		T_J, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	$R_{\theta JC}$		3.5	°C / W
Junction-to-Ambient	$R_{\theta JA}$		62.5	

¹Pulse width limited by maximum junction temperature.

²Duty cycle ≤ 1%

ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$, Unless Otherwise Noted)

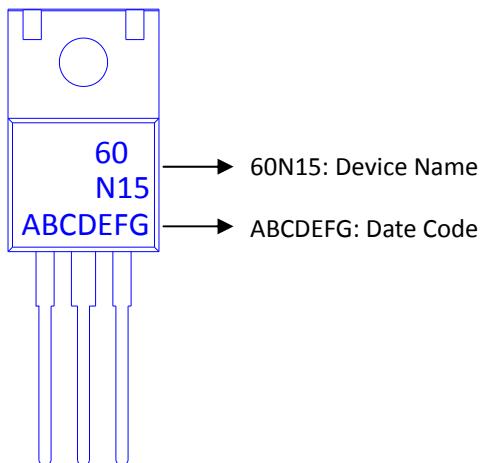
PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	150			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	2.0	3.0	4.5	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 30V$			± 100	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 120V, V_{GS} = 0V$			1	μA
		$V_{DS} = 100V, V_{GS} = 0V, T_J = 125^\circ\text{C}$			25	
On-State Drain Current ¹	$I_{D(\text{ON})}$	$V_{DS} = 10V, V_{GS} = 10V$	20			A
Drain-Source On-State Resistance ¹	$R_{DS(\text{ON})}$	$V_{GS} = 10V, I_D = 20\text{A}$		50	60	$\text{m}\Omega$
		$V_{GS} = 7V, I_D = 20\text{A}$		58	70	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 5V, I_D = 20\text{A}$		25		s
DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 25V, f = 1\text{MHz}$		2903		pF
Output Capacitance	C_{oss}			172		
Reverse Transfer Capacitance	C_{rss}			59		
Gate Resistance	R_g	$V_{GS} = 15\text{mV}, V_{DS} = 0V, f = 1\text{MHz}$		2.3		Ω
Total Gate Charge ^{1,2}	Q_g	$V_{DS} = 80V, V_{GS} = 10V, I_D = 20\text{A}$		38.2		nC
Gate-Source Charge ^{1,2}	Q_{gs}			9.8		
Gate-Drain Charge ^{1,2}	Q_{gd}			14.5		
Turn-On Delay Time ^{1,2}	$t_{d(\text{on})}$	$V_{DS} = 75V, I_D = 1\text{A}, V_{GS} = 10V, R_{GS} = 6\Omega$		15		nS
Rise Time ^{1,2}	t_r			40		
Turn-Off Delay Time ^{1,2}	$t_{d(\text{off})}$			45		
Fall Time ^{1,2}	t_f			38		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_c = 25^\circ\text{C}$)						
Continuous Current	I_s				20	A
Pulsed Current ³	I_{SM}				80	
Forward Voltage ¹	V_{SD}	$I_F = I_s, V_{GS} = 0V$			1.3	V
Reverse Recovery Time	t_{rr}	$I_F = 20\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		100		nS
Reverse Recovery Charge	Q_{rr}			360		

¹Pulse test : Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.

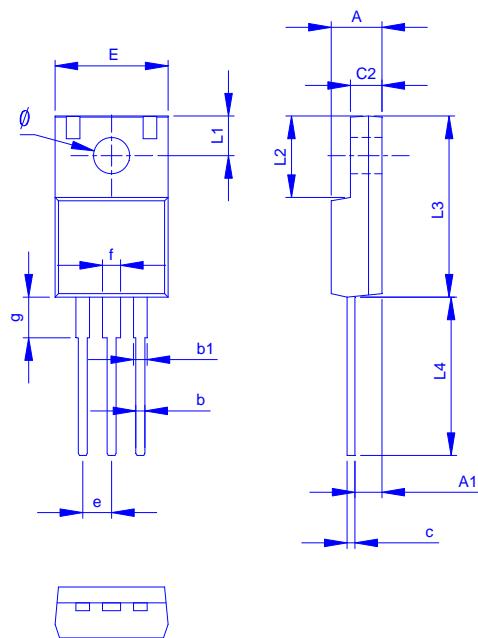
³Pulse width limited by maximum junction temperature.

Ordering & Marking Information:

Device Name: LB60N15GF for TO-220F



Outline Drawing



Dimension in mm

Dimension	A	A1	b	b1	c	c2	E	L1	L2	L3	L4	φ	e	f	g
Min.	4.20	1.95	0.50	0.90	0.45	2.34	9.70	2.70	6.48	14.80	12.68	3.00	2.35	1.18	3.13
Max.	4.90	2.96	1.05	1.50	0.80	3.20	10.66	3.80	7.50	16.30	14.50	3.50	2.75	1.90	4.00

TYPICAL CHARACTERISTICS

